

**Search Notes**

Application No.

09/615,097

Examiner

Len Tran

Applicant(s)

WEYER ET AL.

Art Unit

1725

**SEARCHED**

Class	Subclass	Date	Examiner
164	441, 442	10/22/2003	LT
	444, 413,		
	454		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
164	Same above	10/22/2003	LT

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EASt and Palm for double Patenting	10/22/2003	LT